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SN54LV74A, SN74LV74A

SCLS381M-AUGUST 1997-REVISED MARCH 2015

SNx4LV74A Dual Positive-Edge-Triggered D-Type Flip-Flops

1 Features

- 2-V to 5.5-V V_{CC} Operation
- Maximum t_{pd} of 8.5 ns at 5 V
- Typical V_{OLP} (Output Ground Bounce) < 0.8 V at V_{CC} = 3.3 V, $T_A = 25^{\circ}C$
- Typical V_{OHV} (Output V_{OH} Undershoot) > 2.3 V at V_{CC} = 3.3 V, T_A = 25° C
- Support Mixed-Mode Voltage Operation on All Ports
- I_{off} Supports Partial-Power-Down Mode Operation
- Latch-up Performance Exceeds 250 mA
 Per JESD 17
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 500-V Charged-Device Model (C101)

2 Applications

- Programmable Logic Controller (PLC)
- DCS and PAC: Analog Input Module
- AV Receiver
- Server PSU
- STB, DVR, and Streaming Media (Withdraw)
- Server Motherboard

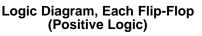
3 Description

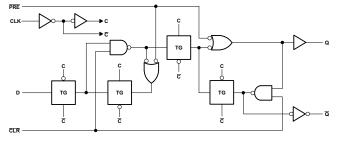
These dual positive-edge-triggered D-type flip-flops are designed for 2-V to 5.5-V V_{CC} operation.

Device Information⁽¹⁾

-		•
PART NUMBER	PACKAGE	BODY SIZE (NOM)
	VQFN (14)	3.50 mm × 3.50 mm
	SOIC (14)	8.65 mm × 3.91 mm
SN74LV74A	SOP (14)	10.30 mm × 5.30 mm
	SSOP (14)	6.20 mm × 5.30 mm
	TSSOP (14)	5.00 mm × 4.40 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.







1

Table of Contents

1	Feat	ures 1
2	Арр	lications1
3	Desc	cription 1
4	Revi	sion History 2
5	Pin (Configuration and Functions 3
6	Spee	cifications 4
	6.1	Absolute Maximum Ratings 4
	6.2	ESD Ratings 4
	6.3	Recommended Operating Conditions 5
	6.4	Electrical Characteristics5
	6.5	Switching Characteristics: $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V} \dots 6$
	6.6	Switching Characteristics: V _{CC} = 3.3 V \pm 0.3 V 6
	6.7	Switching Characteristics: $V_{CC} = 5 V \pm 0.5 V$ 6
	6.8	Timing Requirements: V_{CC} = 2.5 V ± 0.2 V 6
	6.9	Timing Requirements: V_{CC} = 3.3 V ± 0.3 V7
	6.10	Timing Requirements: $V_{CC} = 5 V \pm 0.5 V$
	6.11	Noise Characteristics 7
	6.12	Operating Characteristics7
	6.13	Typical Characteristics 8

7	Para	meter Measurement Information	9
8	Deta	iled Description	10
	8.1	Overview	10
	8.2	Functional Block Diagram	10
	8.3	Feature Description	10
	8.4	Device Functional Modes	11
9	Appl	ication and Implementation	12
	9.1	Application Information	12
	9.2	Typical Application	
10	Pow	er Supply Recommendations	14
11	Layo	out	14
	11.1	Layout Guidelines	14
	11.2	Layout Example	14
12	Devi	ice and Documentation Support	15
	12.1	Documentation Support	15
	12.2	Trademarks	15
	12.3	Electrostatic Discharge Caution	15
	12.4	Glossary	15
13	Mec	hanical, Packaging, and Orderable	
		mation	15

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision L (April 2005) to Revision M

Page

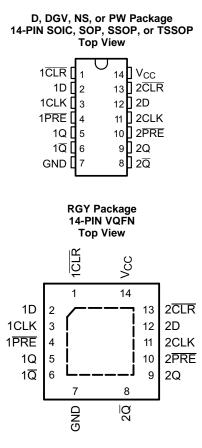
Added Pin Configuration and Functions section, ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device Removed Ordering Information table. 1

EXAS **ISTRUMENTS**

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5 Pin Configuration and Functions



Pin Functions

PIN		1/0	DESCRIPTION
NO.	NAME	I/O	DESCRIPTION
1	1CLR	I	1 clear
2	1D	I	1D input
3	1CLK	I	1 clock
4	1PRE	I	1 preset
5	1Q	0	1Q output
6	1Q	0	1Q output
7	GND	-	GND
8	2 <u>Q</u>	0	2Q output
9	2Q	0	2Q output
10	2PRE	I	2 preset
11	2CLK	I	2 clock
12	2D	I	2D input
13	2 CLR	I	2 clear
14	Vcc	_	Supply voltage input

6 Specifications

6.1 Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V _{CC}	Supply voltage		-0.5	7	V
VI	Input voltage ⁽²⁾		-0.5	7	V
Vo	Voltage applied to any output in the hig	h-impedance or power-off state ⁽²⁾	-0.5	7	V
Vo	Output voltage ⁽²⁾⁽³⁾		-0.5	V _{CC} + 0.5	V
I _{IK}	Input clamp current	V ₁ < 0		-20	mA
I _{OK}	Output clamp current	V _O < 0		-50	mA
I _O	Continuous output current	$V_{O} = 0$ to V_{CC}		±25	mA
	Continuous current through V _{CC} or GN			±50	mA
		D package ⁽⁴⁾		86	
		DB package ⁽⁴⁾		96	
0	De she ve the much immediate	DGV package ⁽⁴⁾		127	
θ_{JA}	Package thermal impedance	NS package ⁽⁴⁾		76	°C/W
		PW package ⁽⁴⁾		113	
		RGY package ⁽⁵⁾		47	
T _{stg}	Storage temperature		-65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

(3) This value is limited to 5.5 V maximum.

(4) The package thermal impedance is calculated in accordance with JESD 51-7.

(5) The package thermal impedance is calculated in accordance with JESD 51-5.

6.2 ESD Ratings

			VALUE	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	2000	
V _(ESD)	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	500	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			SN54LV	74A ⁽²⁾	SN74L	.V74A	
			MIN	MAX	MIN	MAX	UNIT
V _{CC}	Supply voltage		2	5.5	2	5.5	V
		$V_{CC} = 2 V$	1.5				
		V_{CC} = 2.3 V to 2.7 V	$V_{CC} \times 0.7$		$V_{CC} \times 0.7$		V
VIH	High-level input voltage	$V_{CC} = 3 V \text{ to } 3.6 V$	$V_{CC} \times 0.7$		$V_{CC} \times 0.7$		v
		V_{CC} = 4.5 V to 5.5 V	$V_{CC} \times 0.7$		$V_{CC} \times 0.7$		
		$V_{CC} = 2 V$		0.5		0.5	
V		V_{CC} = 2.3 V to 2.7 V		$V_{CC} \times 0.3$		$V_{CC} \times 0.3$	V
V _{IL}	Low-level input voltage	$V_{CC} = 3 V$ to 3.6 V		$V_{CC} \times 0.3$		$V_{CC} \times 0.3$	v
		V_{CC} = 4.5 V to 5.5 V		$V_{CC} \times 0.3$		$V_{CC} \times 0.3$	
VI	Input voltage		0	5.5	0	5.5	V
Vo	Output voltage		0	V _{CC}	0	V _{CC}	V
		$V_{CC} = 2 V$		-50		-50	μA
	High lovel output ourrent	V_{CC} = 2.3 V to 2.7 V		-2		-2	
I _{OH}	High-level output current	V_{CC} = 3 V to 3.6 V		-6		-6	mA
		V_{CC} = 4.5 V to 5.5 V		-12		-12	
		$V_{CC} = 2 V$		50		50	μA
	Low lovel output ourrent	V_{CC} = 2.3 V to 2.7 V		2		2	
I _{OL}	Low-level output current	V_{CC} = 3 V to 3.6 V		6		6	mA
		V_{CC} = 4.5 V to 5.5 V		12		12	
		V_{CC} = 2.3 V to 2.7 V		200		200	
Δt/Δv	Input transition rise or fall rate	V_{CC} = 3 V to 3.6 V		100		100	ns/V
		V_{CC} = 4.5 V to 5.5 V		20		20	
T _A	Operating free-air temperature		-55	125	-40	125	°C

(1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, SCBA004.

(2) Product Preview

6.4 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{cc}	SN54	LV74A ⁽¹⁾			4LV74 <i>4</i> C to 85°			N74LV74A °C to 125°		UNIT
			MIN	TYP	мах	MIN	ТҮР	MAX	MIN	TYP	MAX	
	I _{OH} = -50 μA	2 V to 5.5 V	V _{CC} 0.1			V _{CC} –0. 1			V _{CC} -0.1			
V _{OH}	I _{OH} = -2 mA	2.3 V	2			2			2			V
	I _{OH} = -6 mA	3 V	2.48			2.48			2.48			
	I _{OH} = -12 mA	4.5 V	3.8			3.8			3.8			
	I _{OL} = 50 μA	2 V to 5.5 V			0.1			0.1			0.1	
N	$I_{OL} = 2 \text{ mA}$	2.3 V			0.4			0.4			0.4	V
V _{OL}	$I_{OL} = 6 \text{ mA}$	3 V			0.44			0.44			0.44	v
	I _{OL} = 12 mA	4.5 V			0.55			0.55			0.55	
I _I	$V_1 = 5.5 V \text{ or GND}$	0 to 5.5 V			±1			±1			±1	μA
Icc	$V_I = V_{CC} \text{ or } GND, I_O = 0$	5.5 V			20			20			20	μA
I _{off}	$V_1 \text{ or } V_0 = 5.5 \text{ V}$	0			5			5			5	μA
<u> </u>	V = V or CND	3.3 V		2			2			2		'n
Ci	$V_{I} = V_{CC}$ or GND	5 V		2			2			2		pF

(1) Product Preview

SN54LV74A, SN74LV74A

SCLS381M-AUGUST 1997-REVISED MARCH 2015

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6.5 Switching Characteristics: V_{cc} = 2.5 V ± 0.2 V

over recommended operating free-air temperature range, $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}$ (unless otherwise noted) (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE		T _A = 25°C	;	SN54LV	74A ⁽¹⁾	SN74L –40°C t		SN74L\ –40°C to		UNIT
	(INPOT)	(001F01)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
£			C _L = 15 pF	50 ⁽²⁾	100 ⁽²⁾		40 ⁽²⁾		40		40		MHz
t _{max}			C _L = 50 pF	30	70		25		25		25		IVITIZ
	PRE or CLR	Q or Q	0 15 55		9.8 ⁽²⁾	14.8 ⁽²⁾	1 ⁽²⁾	17 ⁽²⁾	1	17	1	18	
t _{pd}	CLK	QorQ	C _L = 15 pF		11.1 ⁽²⁾	16.4 ⁽²⁾	1 ⁽²⁾	19 ⁽²⁾	1	19	1	20	ns
	PRE or CLR	Q or \overline{Q}			13	17.4	1	20	1	20	1	21	
t _{pd}	CLK	Q OF Q	C _L = 50 pF		14.2	20	1	23	1	23	1	24	ns

(1) Product Preview

(2) On products compliant to MIL-PRF-38535, this parameter is not production tested.

6.6 Switching Characteristics: $V_{cc} = 3.3 V \pm 0.3 V$

over recommended operating free-air temperature range, $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$ (unless otherwise noted) (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	•	T _A = 25°(с	SN54L	.V74A ⁽¹⁾	SN74L\ -40°C to		SN74L -40°C to		UNIT
	(INPUT)	(001901)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
4			C _L = 15 pF	80 ⁽²⁾	140 ⁽²⁾		70 ⁽²⁾		70		70		MHz
Imax			C _L = 50 pF	50	90		45		45		45		IVITIZ
	PRE or CLR	Q or Q	0 15 55		6.9 ⁽²⁾	12.3 ⁽²⁾	1 ⁽²⁾	14.5 ⁽²⁾	1	14.5	1	15.5	
t _{pd}	CLK	QOIQ	C _L = 15 pF		7.9 ⁽²⁾	11.9 ⁽²⁾	1 ⁽²⁾	14 ⁽²⁾	1	14	1	15	ns
	PRE or CLR	Q or Q			9.2	15.8	1	18	1	18	1	19	20
t _{pd}	CLK		C _L = 50 pF		10.2	15.4	1	17.5	1	17.5	1	18.5	ns

(1) Product Preview

(2) On products compliant to MIL-PRF-38535, this parameter is not production tested.

6.7 Switching Characteristics: $V_{cc} = 5 V \pm 0.5 V$

over recommended operating free-air temperature range, $V_{CC} = 5 V \pm 0.5 V$ (unless otherwise noted) (see Figure 3)

PARAMETER	FROM	TO	LOAD CAPACITANCE	Т	_A = 25°C	;	SN54LV	74A ⁽¹⁾	SN74L –40°C t		SN74L\ -40°C to		UNIT
	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
4			C _L = 15 pF	130 ⁽²⁾	180 ⁽²⁾		110 ⁽²⁾		110		110		MHz
f _{max}			C _L = 50 pF	90	140		75		75		75		IVITIZ
	PRE or CLR	Q or Q	0 15 5		5 ⁽²⁾	7.7 ⁽²⁾	1 ⁽²⁾	9 ⁽²⁾	1	9	1	10	
t _{pd}	CLK	QUIQ	C _L = 15 pF		5.6 ⁽²⁾	7.3 ⁽²⁾	1 ⁽²⁾	8.5 ⁽²⁾	1	8.5	1	9.5	ns
	PRE or CLR	Q or Q	0 50 55		6.6	9.7	1	11	1	11	1	12	
t _{pd}	CLK	QUIQ	C _L = 50 pF		7.2	9.3	1	10.5	1	10.5	1	11.5	ns

(1) Product Preview

(2) On products compliant to MIL-PRF-38535, this parameter is not production tested.

6.8 Timing Requirements: $V_{cc} = 2.5 V \pm 0.2 V$

over recommended operating free-air temperature range, $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}$ (unless otherwise noted) (see Figure 3)

			T _A = 25°C		SN54LV74A ⁽¹⁾		SN74L –40°C to		SN74LV74A 40°C to 125°C		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
	Pulse duration	PRE or CLR low	8		9		9		9		5
^L W		CLK	8		9		9		9		ns
	Setup time before CLK↑	Data	8		9		9		9		5
ι _{su}		PRE or CLR inactive	7		7		7		7		ns
t _h	t _h Hold time, data after CLK↑		0.5		0.5		0.5		0.5		ns

(1) Product Preview

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6.9 Timing Requirements: V_{cc} = 3.3 V ± 0.3 V

over recommended operating free-air temperature range, V_{CC} = 3.3 V ± 0.3 V (unless otherwise noted) (see Figure 3)

			T _A = 2	5°C	SN54LV	74A ⁽¹⁾	SN74L\ -40°C to		SN74LV74A 40°C to 125°C		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t Dulas duration	PRE or CLR low	6		7		7		7			
۱w	Pulse duration	CLK	6		7		7		7		ns
	Cotup time before CLI/A	Data	6		7		7		7		
t _{su}	Setup time before CLK↑	PRE or CLR inactive	5		5		5		5		ns
t _h	Hold time, data after CLK↑		0.5		0.5		0.5		0.5		ns

(1) Product Preview

6.10 Timing Requirements: $V_{cc} = 5 V \pm 0.5 V$

over recommended operating free-air temperature range, $V_{CC} = 5 V \pm 0.5 V$ (unless otherwise noted) (see Figure 3)

			T _A = 25°C		T _A = 25°C SN54LV74A ⁽¹⁾			/74A 0 85°C	SN74LV74A -40°C to 125°C		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
	Dulas duration	PRE or CLR low	5		5		5		5		
۱w	Pulse duration	CLK	5		5		5		5		ns
	Cature time bafare CLI/A	Data	5		5		5		5		
τ _{su}	Setup time before CLK↑	PRE or CLR inactive	3		3		3		3		ns
t _h	Hold time, data after CLK↑	· ·	0.5		0.5		0.5		0.5		ns

(1) Product Preview

6.11 Noise Characteristics⁽¹⁾

 $V_{CC}=3.3~V,~C_L=50~pF,~T_A=25^\circ C$

	PARAMETER	SN	74LV74	A	UNIT
	PARAMEIER	MIN	TYP	MAX	UNIT
V _{OL(P)}	Quiet output, maximum dynamic V _{OL}		0.1	0.8	V
V _{OL(V)}	Quiet output, minimum dynamic V _{OL}		0	-0.8	V
V _{OH(V)}	Quiet output, minimum dynamic V _{OH}		3.2		V
V _{IH(D)}	High-level dynamic input voltage	2.31			V
V _{IL(D)}	Low-level dynamic input voltage			0.99	V

(1) Characteristics are for surface-mount packages only.

6.12 **Operating Characteristics**

 $T_A = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS	V _{cc}	TYP	UNIT
	Device discipation accesitence		3.3 V	21	Ē
C	P _{pd} Power dissipation capacitance	$C_L = 50 \text{ pF}$ f = 10 MHz	5 V	23	pF

SN54LV74A, SN74LV74A

0

-100

-50

SCLS381M-AUGUST 1997-REVISED MARCH 2015

0 50 Temperature

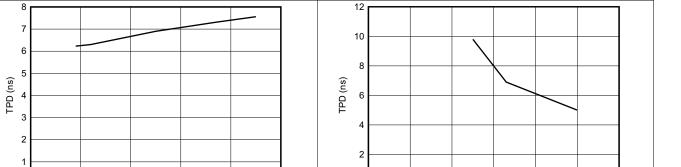
Figure 1. TPD vs. Temperature at 3.3 V

50

100

150

D001



0

0

1

2

3 VCC

Figure 2. TPD vs. VCC at 25°C

4

5

6

D002

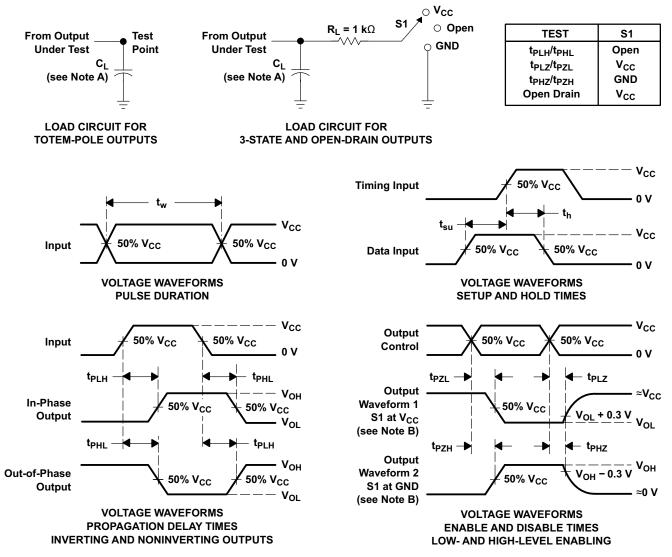


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7 Parameter Measurement Information



- NOTES: A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_r \leq 3 ns, t_f \leq 3 ns.
 - D. The outputs are measured one at a time, with one input transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. t_{PZL} and t_{PZH} are the same as t_{en} .
 - G. t_{PHL} and t_{PLH} are the same as t_{pd} .
 - H. All parameters and waveforms are not applicable to all devices.

Figure 3. Load Circuit and Voltage Waveforms

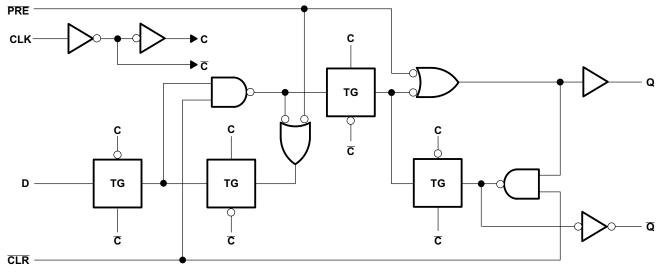
8 Detailed Description

8.1 Overview

These dual positive-edge-triggered D-type flip-flops are designed for 2-V to 5.5-V V_{CC} operation.

A low level at the preset (PRE) or clear (CLR) inputs sets or resets the outputs, regardless of the levels of the other inputs. When PRE and CLR are inactive (high), data at the data (D) inputs meeting the setup-time requirements is transferred to the outputs on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the levels at the outputs. The state of the output upon power-up is not known until the first valid clock edge has occurred while V_{CC} is within *Recommended Operating Conditions*.

These devices are fully specified for partial-power-down applications using I_{off}. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down.



8.2 Functional Block Diagram

Figure 4. Logic Diagram, Each Flip-Flop (Positive Logic)

8.3 Feature Description

The device's wide operating range allows it to be used in a variety of systems that use different logic levels. The low propagation delay allows fast switching and higher speeds of operation. In addition, the low ground bounce stabilizes the performance of non-switching outputs while another output is switching.



8.4 Device Functional Modes

	I	NPUTS		OUT	PUTS
PRE	CLR	CLK	D	Q	Q
L	Н	Х	Х	Н	L
Н	L	Х	Х	L	Н
L	L	Х	Х	H ⁽¹⁾	H ⁽¹⁾
Н	Н	Ť	Н	н	L
Н	Н	Ť	L	L	Н
Н	н	L	Х	Q_0	\overline{Q}_0

Table 1. Function Table

(1) This configuration is nonstable; that is, it does not persist when $\overline{\text{PRE}}$ or $\overline{\text{CLR}}$ returns to its inactive (high) level.



9 Application and Implementation

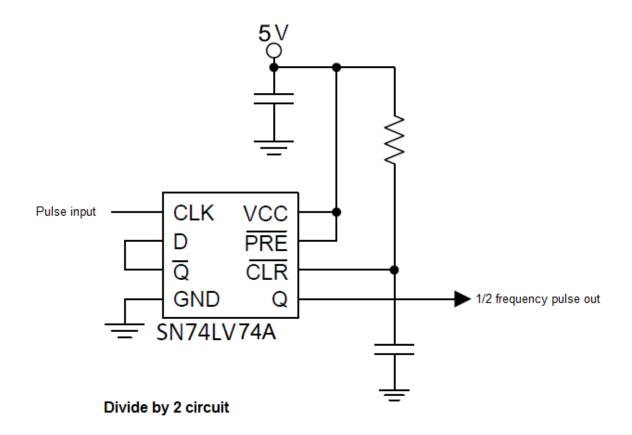
NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The SN74LV74A is a Low drive CMOS device that can be used for a multitude of bus interface type applications where output ringing is a concern. The low drive and slow edge rates will minimize overshoot and undershoot on the outputs. The inputs can accept voltages to 5.5 V at any valid V_{CC} making it Ideal for down translation.

9.2 Typical Application





9.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Take care to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads so consider routing and load conditions to prevent ringing.



Typical Application (continued)

9.2.2 Detailed Design Procedure

- Recommended input conditions:
 - Specified High and low levels. See (V_{IH} and V_{IL}) in *Recommended Operating Conditions*.
 - Inputs are overvoltage tolerant allowing them to go as high as 5.5 V at any valid V_{CC} .
- Recommended output conditions:
 - Load currents should not exceed 25 mA per output and 50 mA total for the part.
 - Outputs should not be pulled above V_{CC}.

9.2.3 Application Curves

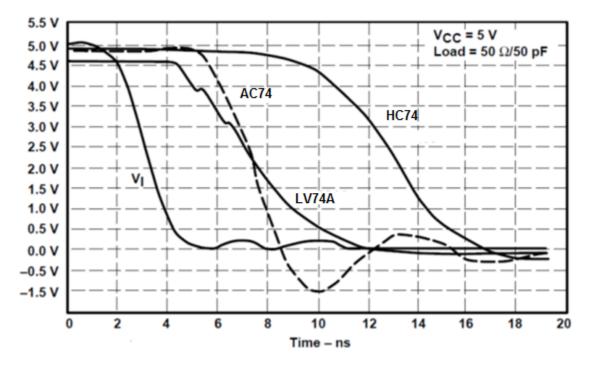


Figure 6. Switching Characteristics Comparison

10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*.

Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, TI recommends a 0.1- μ F capacitor and if there are multiple V_{CC} terminals then TI recommends a 0.01- μ F or 0.022- μ F capacitor for each power terminal. Multiple bypass capacitors can be paralleled to reject different frequencies of noise. Frequencies of 0.1 μ F and 1 μ F are commonly used in parallel. The bypass capacitor should be installed as close as possible to the power terminal for best results.

11 Layout

11.1 Layout Guidelines

When using multiple bit logic devices inputs should not ever float.

In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input AND gate are used or only three of the four buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Specified below are the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or V_{CC} whichever make more sense or is more convenient. Floating outputs is generally acceptable, unless the part is a transceiver. If the transceiver has an output enable pin it will disable the outputs section of the part when asserted. This will not disable the input section of the I.O's so they also cannot float when disabled.

11.2 Layout Example



Figure 7. Layout Recommendation



12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

For related documentation see the following: Implications of Slow or Floating CMOS Inputs, SCBA004

12.2 Trademarks

All trademarks are the property of their respective owners.

12.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.4 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



10-Dec-2020

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
	(.)		Ū			(=)	(6)	(3)		()	
SN74LV74AD	ACTIVE	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV74A	Samples
SN74LV74ADBR	ACTIVE	SSOP	DB	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV74A	Samples
SN74LV74ADGVR	ACTIVE	TVSOP	DGV	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV74A	Samples
SN74LV74ADR	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV74A	Samples
SN74LV74ANSR	ACTIVE	SO	NS	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	74LV74A	Samples
SN74LV74APW	ACTIVE	TSSOP	PW	14	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV74A	Samples
SN74LV74APWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU SN	Level-1-260C-UNLIM	-40 to 125	LV74A	Samples
SN74LV74APWRG4	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV74A	Samples
SN74LV74APWT	ACTIVE	TSSOP	PW	14	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LV74A	Samples
SN74LV74ARGYR	ACTIVE	VQFN	RGY	14	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	LV74A	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.



PACKAGE OPTION ADDENDUM

10-Dec-2020

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF SN74LV74A :

Automotive: SN74LV74A-Q1

Enhanced Product: SN74LV74A-EP

NOTE: Qualified Version Definitions:

- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Enhanced Product Supports Defense, Aerospace and Medical Applications

PACKAGE MATERIALS INFORMATION

www.ti.com

Texas Instruments

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



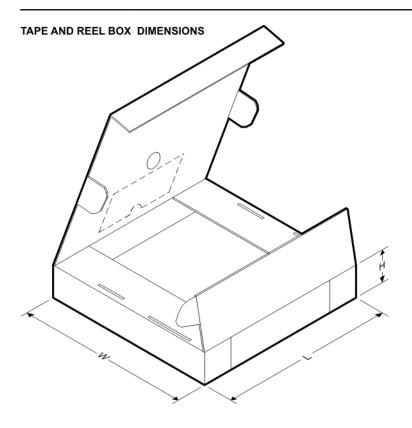
*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LV74ADGVR	TVSOP	DGV	14	2000	330.0	12.4	6.8	4.0	1.6	8.0	12.0	Q1
SN74LV74ADR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74LV74ANSR	SO	NS	14	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
SN74LV74APWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV74APWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV74APWRG4	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV74APWT	TSSOP	PW	14	250	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LV74ARGYR	VQFN	RGY	14	3000	330.0	12.4	3.75	3.75	1.15	8.0	12.0	Q1

Texas Instruments

www.ti.com

PACKAGE MATERIALS INFORMATION

30-Dec-2020



All dimensions are nominal							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LV74ADGVR	TVSOP	DGV	14	2000	853.0	449.0	35.0
SN74LV74ADR	SOIC	D	14	2500	853.0	449.0	35.0
SN74LV74ANSR	SO	NS	14	2000	367.0	367.0	38.0
SN74LV74APWR	TSSOP	PW	14	2000	364.0	364.0	27.0
SN74LV74APWR	TSSOP	PW	14	2000	853.0	449.0	35.0
SN74LV74APWRG4	TSSOP	PW	14	2000	853.0	449.0	35.0
SN74LV74APWT	TSSOP	PW	14	250	853.0	449.0	35.0
SN74LV74ARGYR	VQFN	RGY	14	3000	853.0	449.0	35.0

MECHANICAL DATA



- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- earrow Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated.
- The Pin 1 identifiers are either a molded, marked, or metal feature.
- G. Package complies to JEDEC MO-241 variation BA.



RGY (S-PVQFN-N14)

PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



NOTE: All linear dimensions are in millimeters





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.

D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com http://www.ti.com.

- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



MECHANICAL DATA

PLASTIC SMALL-OUTLINE PACKAGE

0,51 0,35 ⊕0,25⊛ 1,27 8 14 0,15 NOM 5,60 8,20 5,00 7,40 \bigcirc Gage Plane ₽ 0,25 7 1 1,05 0,55 0-10 Δ 0,15 0,05 Seating Plane — 2,00 MAX 0,10PINS ** 14 16 20 24 DIM 10,50 10,50 12,90 15,30 A MAX A MIN 9,90 9,90 12,30 14,70 4040062/C 03/03

NOTES: A. All linear dimensions are in millimeters.

NS (R-PDSO-G**)

14-PINS SHOWN

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



MECHANICAL DATA

PLASTIC SMALL-OUTLINE

MPDS006C - FEBRUARY 1996 - REVISED AUGUST 2000

DGV (R-PDSO-G**)

24 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
- D. Falls within JEDEC: 24/48 Pins MO-153

14/16/20/56 Pins – MO-194



D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



A. An integration of the information o

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



MECHANICAL DATA

MSSO002E - JANUARY 1995 - REVISED DECEMBER 2001

DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-150



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